Search Notes

Application/Control No.	Applicant(s)/Pater Reexamination	nt under
10/660,452	BIEDERMANN E	T AL.
Examiner	Art Unit	
Dave Willse	3738	

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Class	Subclass	Date	Examiner
623	17.13- 17.15	6/19/2006	DW
623	17(FOR)	6/19/2006	DW
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INTERFERENCE SEARCHED				
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SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
searched examiner's collection of foreign patents	6/19/2006	DW